

TOSHIBA BI-DIRECTIONAL TRIODE THYRISTOR SILICON PLANAR TYPE

SM16GZ51, SM16JZ51

AC POWER CONTROL APPLICATIONS

- Repetitive Peak off-State Voltage : $V_{DRM} = 400, 600 \text{ V}$
- R.M.S On-State Current : $I_T (\text{RMS}) = 16 \text{ A}$
- High Commutating (dv / dt) : $(dv / dt)_c = 10 \text{ V} / \mu\text{s}$
- Isolation Voltage : $V_{ISOL} = 1500 \text{ V AC}$

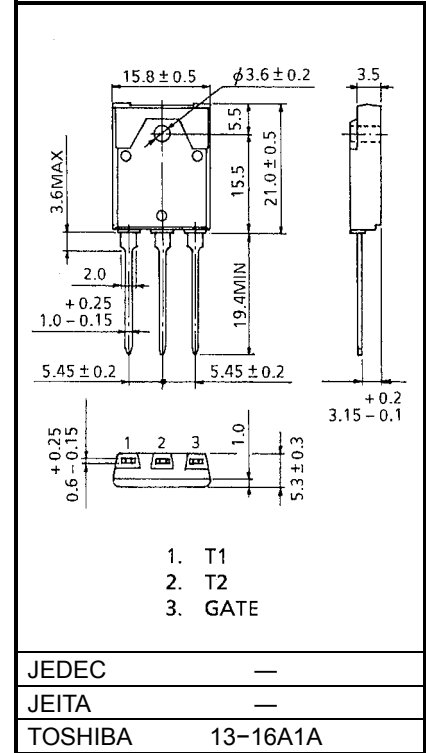
MAXIMUM RATINGS

CHARACTERISTIC	SYMBOL	RATING	UNIT
Repetitive Peak Off-State Voltage	SM16GZ51	400	V
	SM16JZ51	600	
R. M. S. On-state Current (Full Sine Waveform $T_a = 82^\circ\text{C}$)	$I_T (\text{RMS})$	16	A
Peak One Cycle Surge On-State Current (Non-Repetitive)	I_{TSM}	150 (50 Hz)	A
		165 (60 Hz)	
$I^2 t$ Limit Value	$I^2 t$	112.5	A^2s
Critical Rate of Rise of On-State Current (Note 1)	di / dt	50	$\text{A} / \mu\text{s}$
Peak Gate Power Dissipation	P_{GM}	5	W
Average Gate Power Dissipation	$P_G (\text{AV})$	0.5	W
Peak Gate Voltage	V_{GM}	10	V
Peak Gate Current	I_{GM}	2	A
Junction Temperature	T_j	$-40 \sim 125$	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-40 \sim 125$	$^\circ\text{C}$
Isolation Voltage (AC, $t = 1 \text{ min.}$)	V_{ISOL}	1500	V

 Note 1: di / dt test condition

$$V_{DRM} = 0.5 \times \text{Rated}, I_{TM} \leq 25 \text{ A}, t_{gw} \geq 10 \mu\text{s}, t_{gr} \leq 250 \text{ ns}, i_{gp} = I_{GT} \times 2.0$$

Unit: mm

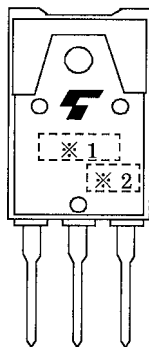


Weight: 2.0g

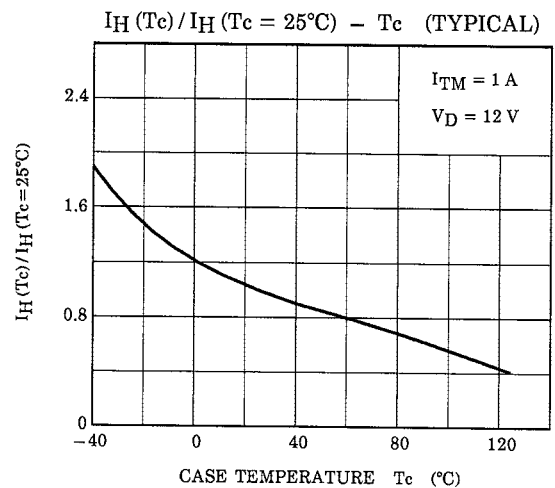
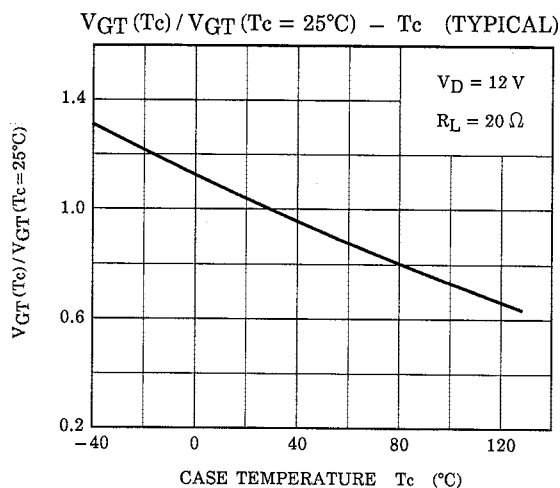
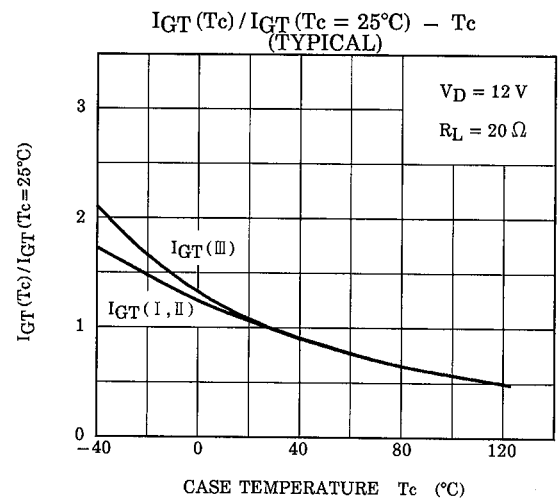
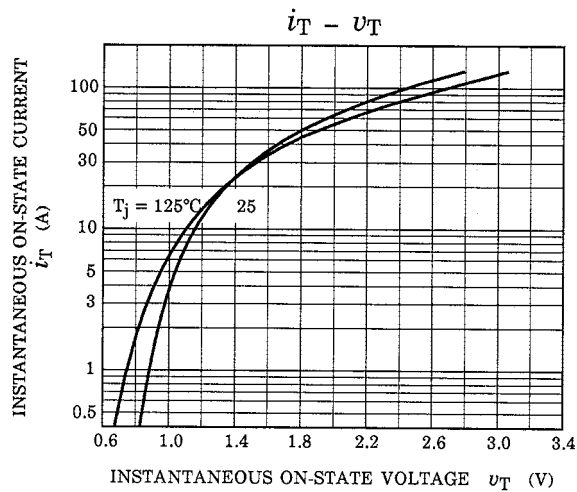
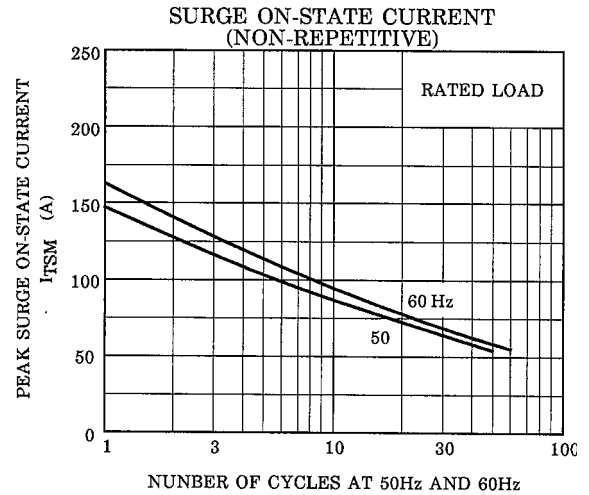
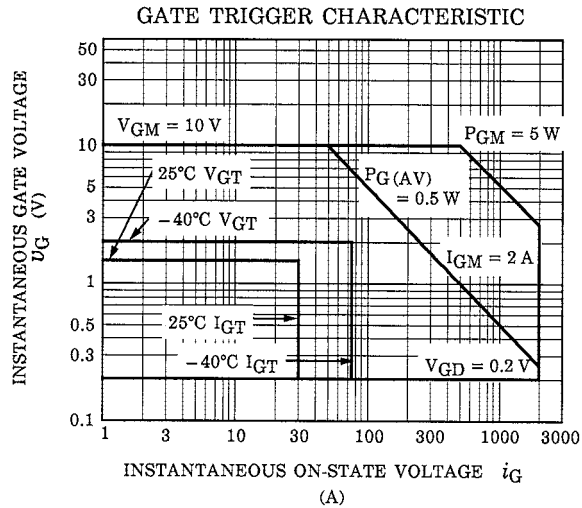
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

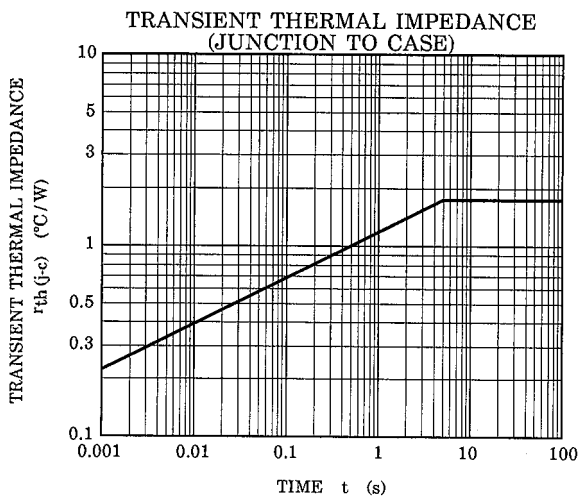
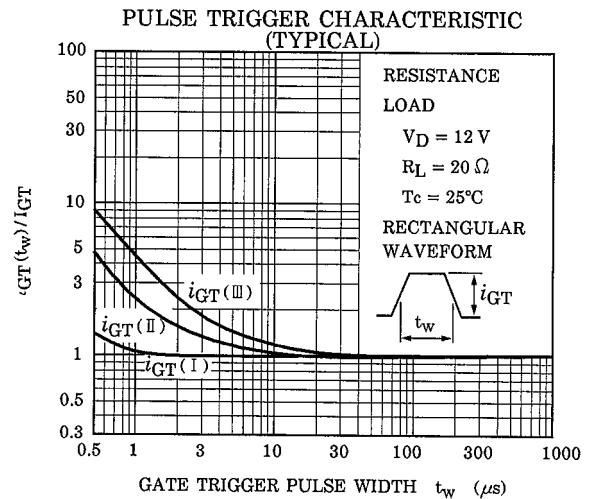
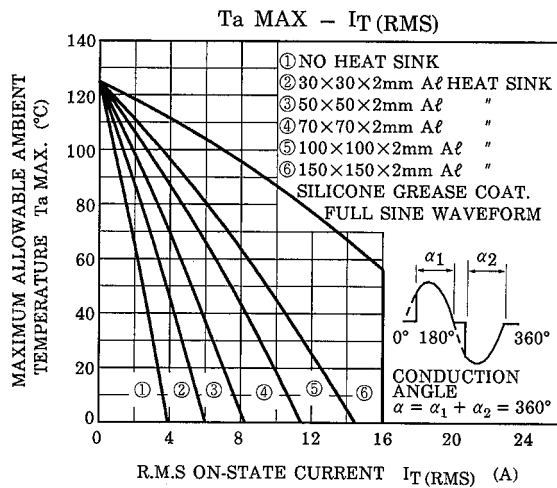
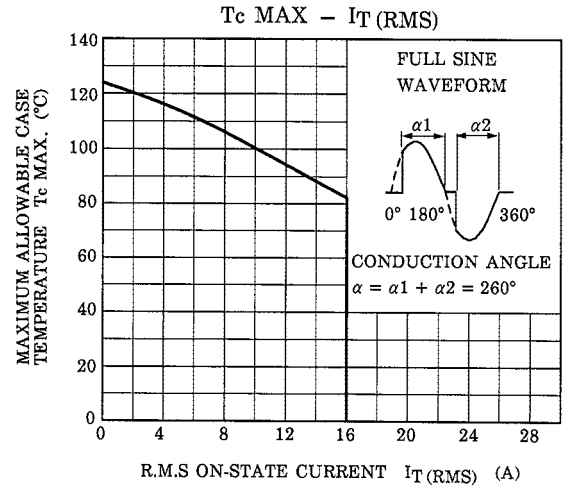
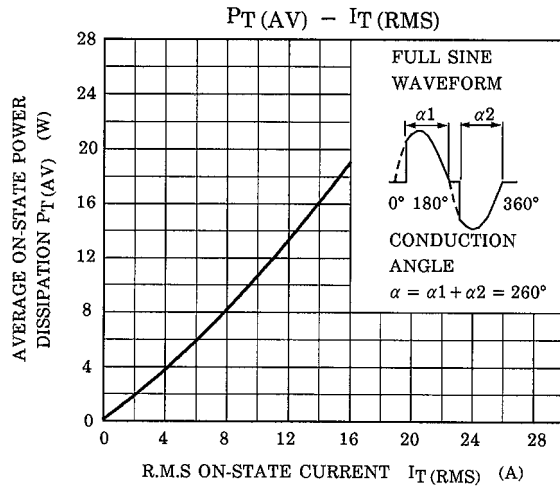
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Repetitive Peak Off-State Current	I_{DRM}	$V_{DRM} = \text{Rated}$	—	—	20	μA
Gate Trigger Voltage	I	$V_D = 12\text{ V}, R_L = 20\ \Omega$	—	—	1.5	V
	II				1.5	
	III				1.5	
	IV				—	
Gate Trigger Current	I	$V_D = 12\text{ V}, R_L = 20\ \Omega$	—	—	30	mA
	II				30	
	III				30	
	IV				—	
Peak On-State Voltage	V_{TM}	$I_{TM} = 25\text{ A}$	—	—	1.5	V
Gate Non-Trigger Voltage	V_{GD}	$V_D = \text{Rated}, T_c = 125^\circ\text{C}$	0.2	—	—	V
Holding Current	I_H	$V_D = 12\text{ V}, I_{TM} = 1\text{ A}$	—	—	50	mA
Thermal Resistance	$R_{th(j-c)}$	Junction to Case, AC	—	—	1.8	$^\circ\text{C} / \text{W}$
Critical Rate of Rise of Off-State Voltage	dv / dt	$V_{DRM} = \text{Rated}, T_j = 125^\circ\text{C}$ Exponential Rise	—	300	—	$\text{V} / \mu\text{s}$
Critical Rate of Rise of Off-State Voltage at Commutation	$(dv / dt)_c$	$V_{DRM} = 400\text{ V}, T_j = 125^\circ\text{C}$ $(di / dt)_c = -8.7\text{ A} / \text{ms}$	10	—	—	$\text{V} / \mu\text{s}$

MARKING



*NUMBER	SYMBOL	MARK
*1	TYPE	M16GZ51
		M16JZ51
*2	Lot Number Month (Starting from Alphabet A) Year (Last Decimal Digit of the Current Year)	Example 8A : January 1998 8B : February 1998 8L : December 1998





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